## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10805016	CHUNG ET AL.
Examiner	Art Unit

3766

SEARCHED				
Class		Subclass	Date	Examiner
607	55-57		5-10-2008	/MB/
updated			11-10-08	/MB/

Mark W Bockelman

SEARCH NOTES		
Search Notes	Date	Examiner
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20081109